Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/807,252	Reexamination TAKEUCHI ET AI	
Examiner	Art Unit	
PRABODH M. DHARIA	2629	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,541,914	04-2003	Ahn, Young Joon	313/586
*	В	US-2004/0041754	03-2004	Inukai, Kazutaka	345/076
*	O	US-7,256,755	08-2007	Ohta et al.	345/68
*	D	US-7,212,178	05-2007	Ishii et al.	345/66
*	Е	US-2004/0155835	08-2004	Ishii et al.	345/060
*	F	US-2004/0090434	05-2004	Miyazawa, Takashi	345/204
*	G	US-5,474,081	12-1995	Livingstone et al.	600/544
*	Н	US-7,209,152	04-2007	Chiaki et al.	345/692
*	_	US-6,950,551	09-2005	Murashita et al.	382/166
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN FATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	т					

NON DATENT DOCUMENTS

NON-PATENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U			
	v			
	w			
	×			

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.